

ParticleMaster

Intelligent Imaging
for Particle & Droplet Sizing



LAVISION

FOCUS ON IMAGING



ParticleMaster Shadow

ParticleMaster Shadow is based on backlight illumination and high-magnification imaging. The shadow of particles in the focal plane of the optics is imaged.

detector: long distance microscope
with high resolution CCD

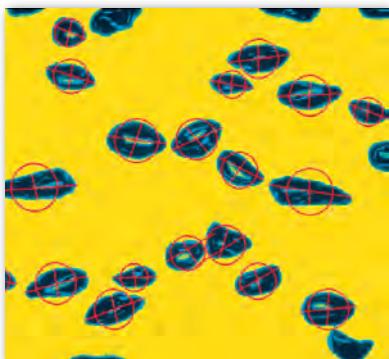


particles, droplets

illumination optics



light source: (pulsed) laser
or (flash) lamp



air bubbles in water

Information

- ▶ particle size (d)
- ▶ particle position (x, y)
- ▶ particle shape (eccentricity)
- ▶ statistics, histograms (D_{10}, D_{32}, D_{v50})
- ▶ velocity (v_x, v_y)
- ▶ density
- ▶ mass flux

Applications

- ▶ liquid sprays (water, fuel, paint, emulsions)
- ▶ spray breakup (ligaments, breakup region)
- ▶ powder, solid particles (alloys, ceramics)
- ▶ bubbles (heat exchangers, industrial processes)

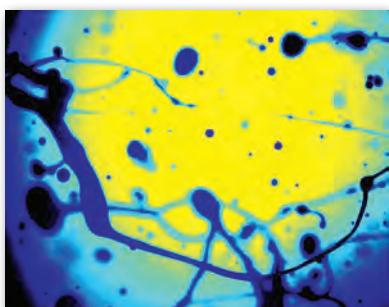
System Components

- ▶ ParticleMaster Shadow Sizing software
- ▶ CCD camera*
- ▶ long distance microscope or macro lens
- ▶ laser*, laser diode flasher or flash lights, illumination optics

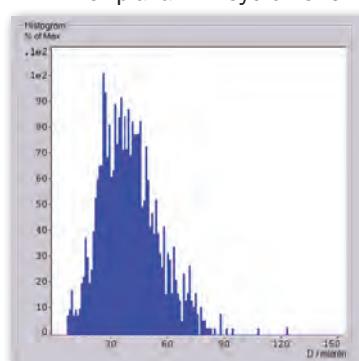
*standard PIV components

Upgrades

- ▶ PIV or planar LIF systems for multi-phase flows



droplets and ligaments in air



particle size histogram



Interferometric Mie Imaging

ParticleMaster IMI

ParticleMaster IMI is based on **Interferometric Mie Imaging**. The spatial Mie scattering intensity distribution is recorded. Size information is obtained from defocused imaging.



$$d = \frac{2 \cdot \lambda}{\Delta\phi} \cdot \left[\cos\left(\frac{\phi}{2}\right) + \frac{n \cdot \sin\left(\frac{\phi}{2}\right)}{\sqrt{1+n^2 - 2 \cdot n \cdot \cos\left(\frac{\phi}{2}\right)}} \right]$$

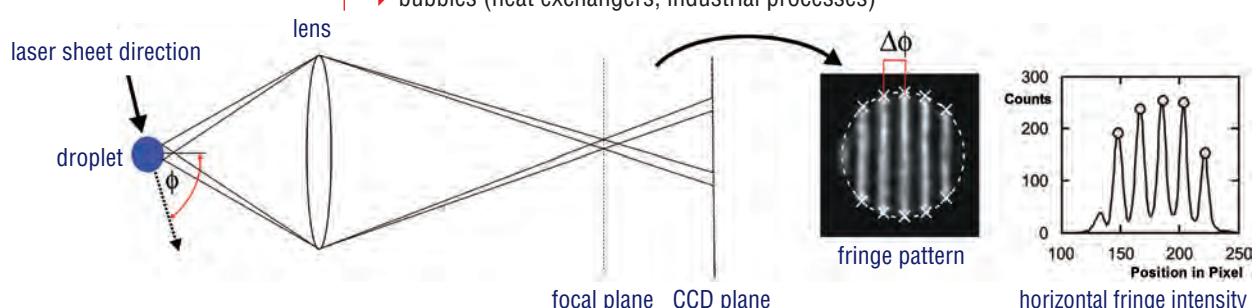
Reference: W. J. Glantschnig, S.-H. Chen, Appl. Opt., 20 (14), 1981.

Information

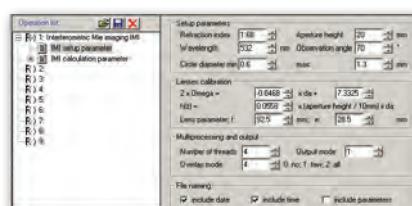
- particle size (d)
- particle position (x, y, z)
- velocity (v_x, v_y, v_z)
- statistics, histograms (D_{10}, D_{32}, D_{v50})
- density
- mass flux

Applications

- transparent sprays (water, fuel, pharma-sprays)
- droplet clouds (evaporation and condensation)
- bubbles (heat exchangers, industrial processes)



Reference: A. Graßmann, F. Peters, personal communication, 10th Fachtagung GALA, Rostock, 2002, 11th Fachtagung GALA, Braunschweig, 2003.



Special IMI Features

- auto-detection and fringe pattern analysis (DaVis IMI Sizing)
- FFT with sub-pixel accuracy & advanced evaluation algorithms
- centroiding algorithm for high-accuracy positioning and velocity determination
- high-aperture macro lens

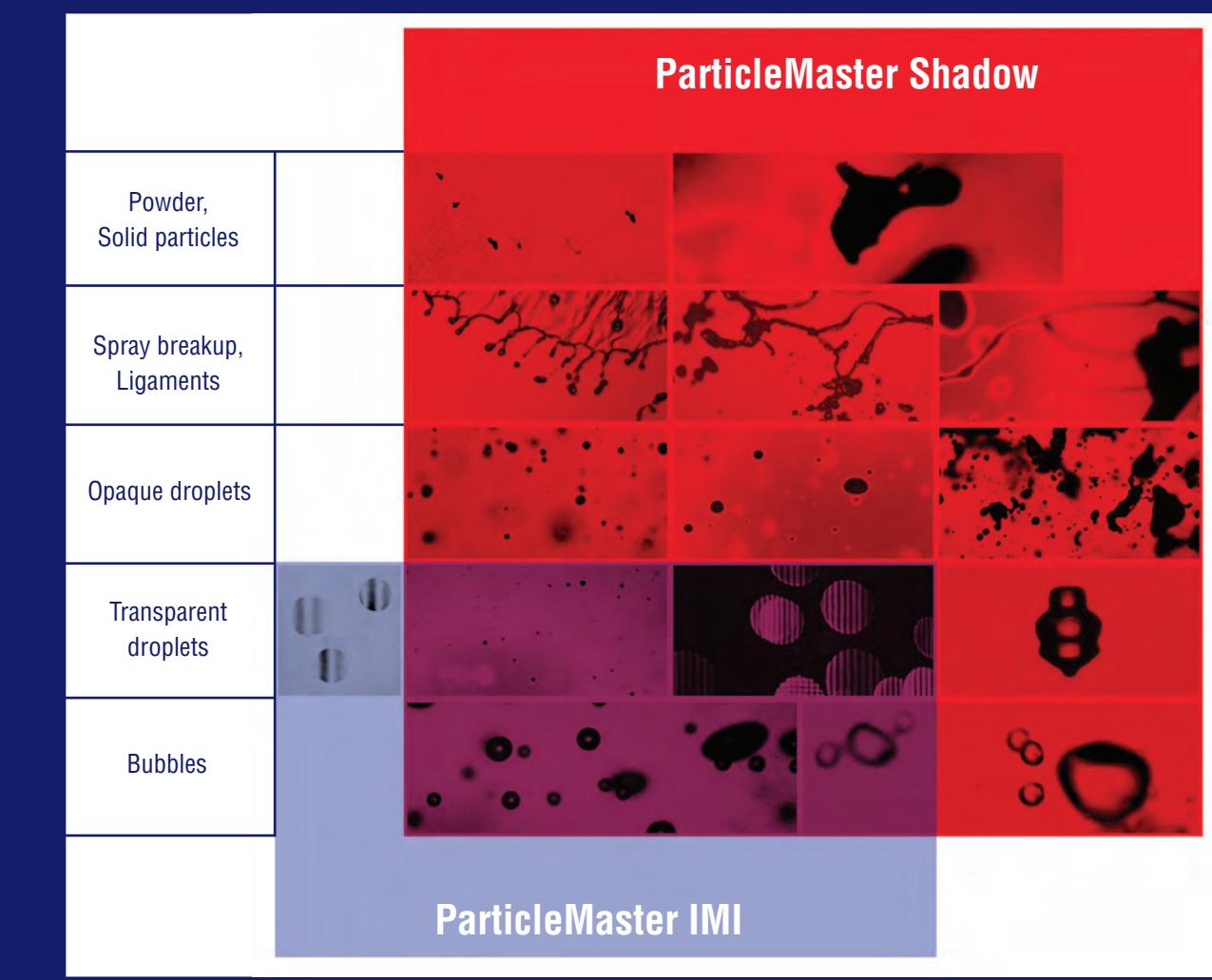
System Components

- ParticleMaster IMI Sizing software
- CCD camera*, macro lens
- laser*, sheet optics*
- *standard PIV components

Upgrades

- PIV or planar LIF systems for multi-phase flows

ParticleMaster Application Matrix



Particle size in μm 2

10

100

1000

	Shadow	IMI
Particle size in μm	> 5	2 - 200
Dynamic range	1:100	1:20
Typ. field of view in mm^2	> 1	50 - 500
Typ. working distance in mm	50 - 1500	50 - 300
Spray density n	$10 n_{\text{IMI}}$	n_{IMI}
Opaque particles	yes	no
Shape	yes	no
Velocity	yes	yes
Morphology	yes	no

LaVisionUK Ltd
 Downsview House / Grove Technology Park
 Grove / Oxon / OX12 9FF / United Kingdom
 E-Mail: sales@lavisionuk.com
www.lavisionUK.com
 Phone: +44-(0)-870-997-6532
 Fax: +44-(0)-870-762-6252

LaVision GmbH
 Anna-Vandenhoeck-Ring 19
 D-37081 Goettingen / Germany
 E-Mail: info@lavision.com
www.lavision.com
 Tel.: +49-(0)5 51-9004-0
 Fax: +49-(0)551-9004-100

LaVision Inc.
 211W. Michigan Ave. / Suite 100
 Ypsilanti, MI 48197 / USA
 E-Mail: sales@lavisioninc.com
www.lavision.com
 Phone: (734) 485 - 0913
 Fax: (240) 465 - 4306